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Substitute for form 1449/PTO		<b>Complete If Known</b>	
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)		Application Number	10/624,746-Conf. #6474
		Filing Date	July 22, 2003
		First Named Inventor	Alastair M. Hodges
		Art Unit	1753
		Examiner Name	A. S. Noguerola
		Attorney Docket Number	104978-0006
Sheet	1	of	1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No. <sup>1</sup>	Document Number	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
		Number-Kind Code <sup>2</sup> (if known)			

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	T <sup>3</sup>
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)				
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/A.N./	CA**	Patent Abstracts of Japan, JP A 04-62463	
	CB**	Patent Abstracts of Japan, JP A 59-3345, p-269, Page 166 (Hitachi Seisakusho K.K.) January 10, 1994	
	CC**	Hubbard, et al. The Theory and Practice of Electrochemistry with Thin Layer Cells, in <i>Electroanalytical Chemistry</i> , (Bard, Ed.), Marcel Dekker, New York, 1970, vol. 4 (pp. 129-214)	
	CD**	Japanese Patent Abstract JP63-139246 A2 (6/1988)	
	CE**	Patent Abstracts of Japan, JP 0 05312761 A2; 1993; Y. Fukuda, et al.	
	CF**	Cassidy, et al.; "Novel Electrochemical Device for the Detection of Cholesterol or Glucose"; <i>Analyst</i> , vol. 118; April 1993; pp. 415-418.	
	CG**	Christensen & Anson: "Chronopotentiometry in Thin Layers of Solution"; <i>Analytical Chemistry</i> , volume 35; No. 2, 1963, pp. 205-209	
	CH**	Hubbard & Anson; "New Electrodes for Chronopotentiometry in Thin Layers of Solution"; <i>Analytical Chemistry</i> , volume 36, No. 4, April 1964, pp. 723-728	
	CI**	McDuffie, Anderson, & Reilly; "Twin Electrode Thin-Layer Electrochemistry"; <i>Analytical Chemistry</i> , volume 38, No. 7, June 1966; pp. 883-890	
/A.N./	CJ**	Nicholson and Shain: "Theory of Stationary Electrode Polarography"; <i>Analytical Chemistry</i> :	
Examiner Signature	/Alexander Noguerola/		Date Considered
			07/23/2007

7/17/07

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/A.N./	CA	JUNG and KWAK; "Simultaneous Determination of Diffusion Coefficient and Concentration by Chronoamperometry at a Microdisk Electrode"; <i>Bull Korean Chem. Soc.</i> ; 1004, V. 15, No. 3, pp. 209-213	
/A.N./	CB	Specification sheet from Adhesives Research, Inc., ARClad@8314 (05/02/97) (1 pg.)	
/A.N./	CC	Specification sheet from Adhesives Research, Inc., ARCare@7148, double-sided adhesive coated polyester film (03/30/95) (2 pages)	
/A.N./	CD	OGLESBY, OMANG, and REILLEY; "Thin Layer Electrochemical Studies Using Controlled Potential or Controlled Current", <i>Analytical Chemistry</i> , Vol. 37, No. 11, October 1965, pp. 1312-1316	

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		vol. 36, No. 4, April 1964, pp. 706-723	
/A.N./	CK**	Pickup, Kutner, Leidner, and Murray; <i>Redox Conduction in Single and Bilayer Films of Redox Polymer</i> ; J. Amer. Chem. Soc.; Vol 106; No. 7; 1984	
	CL**	Chidsey, Feldman, Lundgren, and Murray; <i>"Micrometer-Spaced Platinum Interdigitated Array Electrode: Fabrication, Theory, and Initial Use"</i> ; Analytical Chemistry, vol. 58, No. 3, March 1986, pp. 801-807	
	CM**	Anderson, McDuffie and Reilley; <i>"Diagnostic Criteria for the Study of Chemical and Physical Processes by Twin-Electrode Thin-Layer Electrochemistry"</i> ; J. Electroanalytical Chemistry; vol. 12, 1966, pp. 477-494	
	CN**	Hubbard; <i>"Study of the Kinetics of Electrochemical Reactions by Thin-Layer Voltammetry"</i> ; J. Electroanalytical Chemistry, vol. 22, 1969, pp. 165-174	
	CO**	Anderson and Reilley; <i>"Thin-Layer Electrochemistry: Steady-State Methods of Studying Rate Processes"</i> ; J. Electroanalytical Chemistry; vol. 10, 1965, pp. 295-305	
	CP**	Patent Abstracts of Japan, JP 08062179A; <i>Electrolyte Analyzer</i> , (3/8/96)	
↓	CQ	Reilley, Charles; <i>"Electrochemistry Using Thin-Layer Cells"</i> ; Review of Pure and Appl. Chem, Vol. 18, 1968, pp. 137-151	
/A.N./	CR	Morris, Franta and White; <i>"Electrochemistry at Pt Band Electrodes of Width Approaching Molecular Dimensions. Breakdown of Transport Equations At Very Small Electrodes"</i> ; J. of Physical Chemistry, vol 91, No. 13, 1987, pp. 3559-3564	

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